Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/632,386	STEERE ET AL.		
Examiner	Art Unit		
Tuan V. Thai	2186		

	SEARCHED					
Class	Subclass	Date	Examiner			
711	100	11/21/05	m.			
711	117	V				
711	133					
711	134					
711	135					
711	154	1.1	/			
707	100	11/21/05	4M			
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST searches: USPGPUB DERWENTS EPO/JPO abstract IBMTDB NORTH database				
NPL search IEEE search				
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